SI4936BDY-T1-E3

Dual N-Channel 30-V (D-S) MOSFET

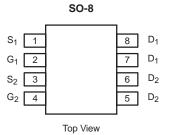
PRODUCT SUMMARY							
V _{DS} (V)	R _{DS(on)} (Ω)	I _D (A)	Q _g (Typ.)				
30	0.022 at V_{GS} = 10 V	6.8	15 nC				
30	0.026 at V _{GS} = 4.5 V	6.0	15110				

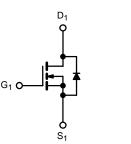
FEATURES

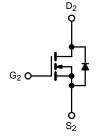
- Halogen-free According to IEC 61249-2-21 Definition
- TrenchFET[®] Power MOSFET
- 100 % UIS Tested
- 100 % Rg Tested
- Compliant to RoHS Directive 2002/95/EC

APPLICATIONS

- Set Top Box
- Low Current DC/DC ٠







N-Channel MOSFET

N-Channel MOSFET

Parameter	Symbol	Limit	Unit		
Drain-Source Voltage		V _{DS}	30	V	
Gate-Source Voltage		V _{GS}	± 20	v	
Continuous Drain Current (T _J = 150 °C)		- I _D -	<u>6.8</u> ^a <u>5.6</u> <u>6.2^{b, c}</u> <u>5.2^{b, c}</u>	A	
Pulsed Drain Current		I _{DM}	30	A	
Continuous Source-Drain Diode Current	T _C = 25 °C T _A = 25 °C	I _S	2.25 1.48 ^{b, c}		
Single Pulse Avalanche Current	L = 0.1 mH	I _{AS}	5		
Single Pulse Avalanche Energy		E _{AS}	1.25	mJ	
Maximum Power Dissipation	$T_{C} = 25 °C$ $T_{C} = 70 °C$ $T_{A} = 25 °C$ $T_{A} = 70 °C$	- P _D -	2.7 1.77 1.78 ^{b, c} 1.14 ^{b, c}	W	
Operating Junction and Storage Temperature	T _J , T _{stg}	- 55 to 150	°C		

THERMAL RESISTANCE RATINGS						
Parameter		Symbol	Typical	Maximum	Unit	
Maximum Junction-to-Ambient ^{a, c, d}	t ≤ 10 s	R _{thJA}	58	70	°C/W	
Maximum Junction-to-Foot (Drain)	Steady State	R _{thJF}	38	45	0/11	

Notes:

a. Package limited, $T_C = 25 \ ^{\circ}C$.

b. Surface Mounted on 1" x 1" FR4 board.

c. t = 10 s.

d. Maximum under Steady State conditions is 110 °C/W.





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COMPLIANT HALOGEN

FREE

$\begin{array}{ $								
	SPECIFICATIONS T _J = 25 °C, unless otherwise noted							
$\begin{array}{c c c c c c c c c c c c c c c c c c c $		Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $				1	Т	1		
$ \begin{array}{ c c c c c c c c c c c c c c c c c c c$			V _{GS} = 0 V, I _D = 250 μA	30			V	
$ \begin{array}{ c c c c c } \hline \mbox{V} \mbox{G} \$			I _D = 250 μA		32			
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	V _{GS(th)} Temperature Coefficient	. ,	- ·		- 5.0		mv/°C	
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	Gate-Source Threshold Voltage	V _{GS(th)}		1.0		2.5	V	
$ \begin{array}{ c c c c c } \hline \mbox{Zero Gate Voltage Drain Current} & I_{DSS} & V_{VSS} = 30 V, V_{QS} = 0 V, T_J = 55 °C & I & I & I & I \\ \hline V_{DS} = 30 V, V_{QS} = 0 V, T_J = 55 °C & I & I & I & I \\ \hline V_{DS} = 5 V, V_{QS} = 10 V & I & I & V_{QS} = 0 & V_{QS} = 10 V & I & I & I \\ \hline V_{DS} = 5 V, V_{QS} = 10 V, I_D = 5 A & 0.022 & V_{QS} = 10 V, I_D = 5 A & I & I & I \\ \hline V_{DS} = 10 V, I_D = 5 A & I & I & I & I \\ \hline V_{DS} = 10 V, I_D = 5 A & I & I & I & I \\ \hline V_{DS} = 10 V, I_D = 5 A & I & I & I & I \\ \hline V_{DS} = 10 V, I_D = 5 A & I & I & I & I \\ \hline U_{DU1 Capacitance} & C_{GS} & V_{DS} = 10 V, I_D = 5 A & I & I & I \\ \hline U_{DU1 Capacitance} & C_{GS} & V_{DS} = 15 V, V_{GS} = 0 V, f = 1 & MHz & 556 & I & I \\ \hline U_{DS} = 15 V, V_{GS} = 0 V, f = 1 & MHz & 556 & I & I & I \\ \hline U_{DS} = 15 V, V_{GS} = 10 V, I_D = 5 A & I & I & I \\ \hline U_{DS} = 15 V, V_{GS} = 10 V, I_D = 5 A & I & I & I \\ \hline U_{DS} = 15 V, V_{GS} = 10 V, I_D = 5 A & I & I & I \\ \hline U_{DS} = 15 V, V_{GS} = 4.5 V, I_D = 5 A & I & I & I \\ \hline U_{DS} = 15 V, V_{GS} = 4.5 V, I_D = 5 A & I & I & I \\ \hline U_{DS} = 15 V, V_{GS} = 4.5 V, I_D = 5 A & I & I & I \\ \hline U_{DS} = 15 V, V_{GS} = 4.5 V, I_D = 5 A & I & I & I \\ \hline U_{DS} = 15 V, V_{GS} = 4.5 V, I_D = 5 A & I & I & I \\ \hline U_{DD} = 15 V, V_{GS} = 4.5 V, I_D = 5 A & I & I & I \\ \hline U_{D} = 5 A, V_{GEN} = 10 V, I_D = 1 & I & I & 22 \\ \hline U_{DD} = 15 V, V_{GS} = 10 V, I_D = 1 & I & I & 22 \\ \hline U_{DD} = 15 V, V_{GS} = 10 V, I_D = 1 & I & I \\ \hline U_{D} = 5 A, V_{GEN} = 10 V, R_g = 1 & I & I & 1 & 22 \\ \hline U_{DD} = 15 V, V_{GS} = 10 V, R_g = 1 & I & 1 & 20 \\ \hline U_{D} = 5 A, V_{GEN} = 10 V, R_g = 1 & I & I & 0 \\ \hline U_{D} = 2 & V_{DD} = 15 V, R_L = 3 & \Omega \\ \hline U_{DD} = 15 V, V_{GS} = 1 & V_{CS} = 1 & I & I & 20 \\ \hline U_{DD} = 15 V, R_L = 3 & \Omega \\ \hline U_{DD} = 15 V, R_L = 3 & \Omega \\ \hline U_{DD} = 15 V, R_L = 3 & \Omega \\ \hline U_{DD} = 15 V, R_L = 1 & 0 & V_{CS} = 1 \\ \hline U_{DD} = 1 & V_{DD} = 1 & V_{CS} = 1 \\ \hline U_{DD} = 1 & V_{DD} = 1 & V_{CS} = 1 \\ \hline U_{DD} = 1 & V_{CS} = 1 & U_{CS} & V_{CS} \\ \hline U_{DD} = 1 & V_{CS} = 1 & U_{CS} & V_{CS} \\ \hline U_{DD} = 1 & V_{CS} = 1 & U_{CS$	Gate-Source Leakage	I _{GSS}				± 100	nA	
$\begin{array}{ c c c c c c } \hline \begin{tabular}{ c c c c c c c } \hline \begin{tabular}{ c c c c c c } \hline \begin{tabular}{ c c c c c c c } \hline \begin{tabular}{ c c c c c c c } \hline \begin{tabular}{ c c c c c c c c } \hline \begin{tabular}{ c c c c c c c c } \hline \begin{tabular}{ c c c c c c c c c c c c c c c c c c c$	Zero Gate Voltage Drain Current	I _{DSS}	$V_{DS} = 30 \text{ V}, V_{GS} = 0 \text{ V}$			1		
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	Zero Gale Voltage Dialit Guitent		V_{DS} = 30 V, V_{GS} = 0 V, T_{J} = 55 °C			10	μA	
$\begin{array}{ c c c c c } \hline Prain-Source On-State Resistance^a & P_{DS(on)} & V_{GS} = 4.5 \ V, \ I_{D} = 4 \ A & 0.026 & I \\ \hline V_{GS} = 4.5 \ V, \ I_{D} = 4 \ A & 0.026 & I \\ \hline V_{GS} = 10 \ V, \ I_{D} = 5 \ A & 16 & S \\ \hline Dynamic^b & & & & & & & & & & & & & & & & & & &$	On-State Drain Current ^a	I _{D(on)}	$V_{DS} \ge 5$ V, V_{GS} = 10 V	10			А	
$ \begin{array}{ c c c c c } \hline V_{CS} = 4.5 \ V, \ V_D = 4.4 & 0.026 & 0.$	Durin Course On Ctate Desistance	Р	$V_{GS} = 10$ V, $I_D = 5$ A		0.022		Ω	
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	Drain-Source On-State Resistance	NDS(on)	$V_{GS} = 4.5 \text{ V}, I_D = 4 \text{ A}$		0.026			
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	Forward Transconductance ^a	9 _{fs}	$V_{DS} = 10 \text{ V}, \text{ I}_{D} = 5 \text{ A}$		16		S	
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	Dynamic ^b			•				
$ \begin{array}{ c c c c c c } \hline Reverse Transfer Capacitance & C_{rss} & & & & & & & & & & & & & & & & & & $	Input Capacitance	C _{iss}			586		pF	
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	Output Capacitance	C _{oss}	V_{DS} = 15 V, V_{GS} = 0 V, f = 1 MHz		117			
$ \begin{array}{ c c c c c c c c c c c c c c c c c c c$	Reverse Transfer Capacitance	C _{rss}			55			
$ \begin{array}{ c c c c c c } \hline \begin{tabular}{ c c c c c } \hline \begin{tabular}{ c c c c c c } \hline \begin{tabular}{ c c c c c c } \hline \begin{tabular}{ c c c c c c c } \hline \begin{tabular}{ c c c c c c c } \hline \begin{tabular}{ c c c c c c c } \hline \begin{tabular}{ c c c c c c c } \hline \begin{tabular}{ c c c c c c c c } \hline \begin{tabular}{ c c c c c c c c c c c c c c c c c c c$	Tatal Cata Charge	0			15		nC	
$ \begin{array}{ c c c c c c } \hline Gate-Source Charge & Q_{gs} & V_{DS} = 15 \ V, \ V_{GS} = 4.5 \ V, \ I_D = 5 \ A & 1.4 & \\ \hline \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \$	Total Gate Charge	Qg			3.7	5.6		
$ \begin{array}{c c c c c c c c c c } \hline Gate Resistance & R_g & f = 1 \ \mbox{MHz} & 0.8 & 4.3 & 8.6 & \Omega \\ \hline Turn-On Delay Time & t_{d(on)} & & & & & & & & & & & & & & & & & & &$	Gate-Source Charge	Q _{gs}			1.4			
$ \begin{array}{c c c c c c c c c } \hline Turn-On Delay Time & t_{d(on)} \\ \hline Rise Time & t_r & V_{DD} = 15 \ V, \ R_L = 3 \ \Omega \\ I_D \cong 5 \ A, \ V_{GEN} = 4.5 \ V, \ R_g = 1 \ \Omega & 11 & 22 \\ \hline Rise Time & t_r & Rise Time & t_r & & & & & & & & & & & & & & & & & & &$	Gate-Drain Charge	Q _{gd}			1.05			
$ \begin{array}{ c c c c c } \hline Rise Time & t_r & V_{DD} = 15 \ V, \ R_L = 3 \ \Omega & 11 & 22 \\ \hline I_D \cong 5 \ A, \ V_{GEN} = 4.5 \ V, \ R_g = 1 \ \Omega & 11 & 22 \\ \hline I_D \cong 5 \ A, \ V_{GEN} = 4.5 \ V, \ R_g = 1 \ \Omega & 11 & 22 \\ \hline I_D \cong 5 \ A, \ V_{GEN} = 4.5 \ V, \ R_g = 1 \ \Omega & 11 & 22 \\ \hline I_D \cong 5 \ A, \ V_{GEN} = 10 \ V, \ R_g = 1 \ \Omega & 10 & 20 \\ \hline I_D \cong 5 \ A, \ V_{GEN} = 10 \ V, \ R_g = 1 \ \Omega & 10 & 20 \\ \hline I_D \cong 5 \ A, \ V_{GEN} = 10 \ V, \ R_g = 1 \ \Omega & 10 & 20 \\ \hline I_D \cong 5 \ A, \ V_{GEN} = 10 \ V, \ R_g = 1 \ \Omega & 10 & 20 \\ \hline I_D \cong 5 \ A, \ V_{GEN} = 10 \ V, \ R_g = 1 \ \Omega & 10 & 20 \\ \hline I_D \cong 5 \ A, \ V_{GEN} = 10 \ V, \ R_g = 1 \ \Omega & 10 & 20 \\ \hline I_D \cong 5 \ A, \ V_{GEN} = 10 \ V, \ R_g = 1 \ \Omega & 10 & 20 \\ \hline I_D \cong 5 \ A, \ V_{GEN} = 10 \ V, \ R_g = 1 \ \Omega & 10 & 20 \\ \hline I_D \cong 5 \ A, \ V_{GEN} = 10 \ V, \ R_g = 1 \ \Omega & 10 & 20 \\ \hline I_D \cong 5 \ A, \ V_{GEN} = 10 \ V, \ R_g = 1 \ \Omega & 10 & 20 \\ \hline I_D \cong 5 \ A, \ V_{GEN} = 10 \ V, \ R_g = 1 \ \Omega & 10 & 20 \\ \hline I_D \cong 5 \ A, \ V_{GEN} = 10 \ V, \ R_g = 1 \ \Omega & 10 & 20 \\ \hline I_D \cong 5 \ A, \ V_{GEN} = 10 \ V, \ R_g = 1 \ \Omega & 10 & 20 \\ \hline I_D \cong 5 \ A, \ V_{GEN} = 10 \ V, \ R_g = 1 \ \Omega & 11 & 20 \\ \hline I_D \cong 5 \ A, \ V_{GEN} = 0 \ V & 0.8 \ 1.2 \ V \\ \hline I_D \cong 0 \ O \ O \ O \ O \ O \ O \ O \ O \ O \$	Gate Resistance	Rg	f = 1 MHz	0.8	4.3	8.6	Ω	
$\begin{tabular}{ c c c c c } \hline Turn-Off Delay Time & t_d(off) & I_D \cong 5 \mbox{ A, } V_{GEN} = 4.5 \mbox{ V, } R_g = 1 \mbox{ \Omega} & 11 & 22 & 8 & 16 & 16$	Turn-On Delay Time	t _{d(on)}			12	24		
$\begin{tabular}{ c c c c c c } \hline Fall Time & t_f & & & & & & & & & & & & & & & & & & &$	Rise Time	t _r	V_{DD} = 15 V, R_L = 3 Ω		55	100	1	
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	Turn-Off Delay Time	t _{d(off)}	$\text{I}_\text{D} \cong$ 5 A, V_GEN = 4.5 V, R_g = 1 Ω		11	22		
$\begin{array}{ c c c c }\hline \mbox{Turn-On Delay Time} & \mbox{t}_{d(on)} & \mbox{t}_{d(on)} & \mbox{t}_{r} & \mbox{V}_{DD} = 15 \ V, \ R_L = 3 \ \Omega & \mbox{D} & $	Fall Time	t _f			8	16		
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	Turn-On Delay Time	t _{d(on)}			4	8	- ns -	
Fall Time t_f 612Drain-Source Body Diode Characteristics612Drain-Source Body Diode Characteristics $T_C = 25 ^{\circ}C$ 2.25Continuous Source-Drain Diode Current I_S $T_C = 25 ^{\circ}C$ 2.25Pulse Diode Forward Current I_SM 24 Body Diode Voltage V_{SD} $I_S = 2 ^{\circ}A, V_{GS} = 0 ^{\circ}V$ 0.81.2Body Diode Reverse Recovery Time t_{rr} 1120nsBody Diode Reverse Recovery Charge Q_{rr} $I_F = 5 ^{\circ}A, dl/dt = 100 ^{\circ}A/\mus, T_J = 25 ^{\circ}C$ 48nCReverse Recovery Fall Time t_a T_a T_a T_a T_a T_a T_a	Rise Time		V_{DD} = 15 V, R_L = 3 Ω		9	18		
$ \begin{array}{c c c c c c c c } \hline Fall Time & t_f & & & & & & & & & & & & & & & & & & &$	Turn-Off Delay Time	t _{d(off)}	$\text{I}_\text{D}\cong \text{5}$ A, V_GEN = 10 V, R_g = 1 Ω		10	20		
$\begin{array}{c c c c c c c c c c c c c c c c c c c $	Fall Time				6	12		
Pulse Diode Forward CurrentI SMI SM24ABody Diode Voltage V_{SD} $I_S = 2 \text{ A}, V_{GS} = 0 \text{ V}$ 0.81.2VBody Diode Reverse Recovery Time t_{rr} 1120nsBody Diode Reverse Recovery Charge Q_{rr} $I_F = 5 \text{ A}, dl/dt = 100 \text{ A/µs}, T_J = 25 ^{\circ}\text{C}$ 48nCReverse Recovery Fall Time t_a T T T T T T	Drain-Source Body Diode Characteristics							
Pulse Diode Forward CurrentI SMI SM24Body Diode Voltage V_{SD} $I_S = 2 \text{ A}, V_{GS} = 0 \text{ V}$ 0.81.2VBody Diode Reverse Recovery Time t_{rr} 1120nsBody Diode Reverse Recovery Charge Q_{rr} $I_F = 5 \text{ A}, dI/dt = 100 \text{ A/µs}, T_J = 25 ^{\circ}\text{C}$ 48nCReverse Recovery Fall Time t_a 7 7 ns	Continuous Source-Drain Diode Current	۱ _S	T _C = 25 °C			2.25	٨	
Body Diode Reverse Recovery Time t_{rr} 1120nsBody Diode Reverse Recovery Charge Q_{rr} Reverse Recovery Fall Time t_a	Pulse Diode Forward Current	I _{SM}				24] ^	
	Body Diode Voltage	V _{SD}	$I_{S} = 2 A, V_{GS} = 0 V$		0.8	1.2	V	
Reverse Recovery Fall Time t_a IF = 5 Å, dl/dt = 100 Å/µs, $I_J = 25 °C$ 7	Body Diode Reverse Recovery Time	-			11	20	ns	
Reverse Recovery Fall Time t _a	Body Diode Reverse Recovery Charge	Q _{rr}			4	8	nC	
Reverse Recovery Rise Time t _b ns	Reverse Recovery Fall Time	ta	$r_F = 5 \text{ A}, \text{ al/al} = 100 \text{ A/}\mu\text{s}, 1_J = 25 \text{ °C}$		7			
	Reverse Recovery Rise Time				4		ns	

Notes:

a. Pulse test; pulse width \leq 300 $\mu s,$ duty cycle \leq 2 %

b. Guaranteed by design, not subject to production testing.

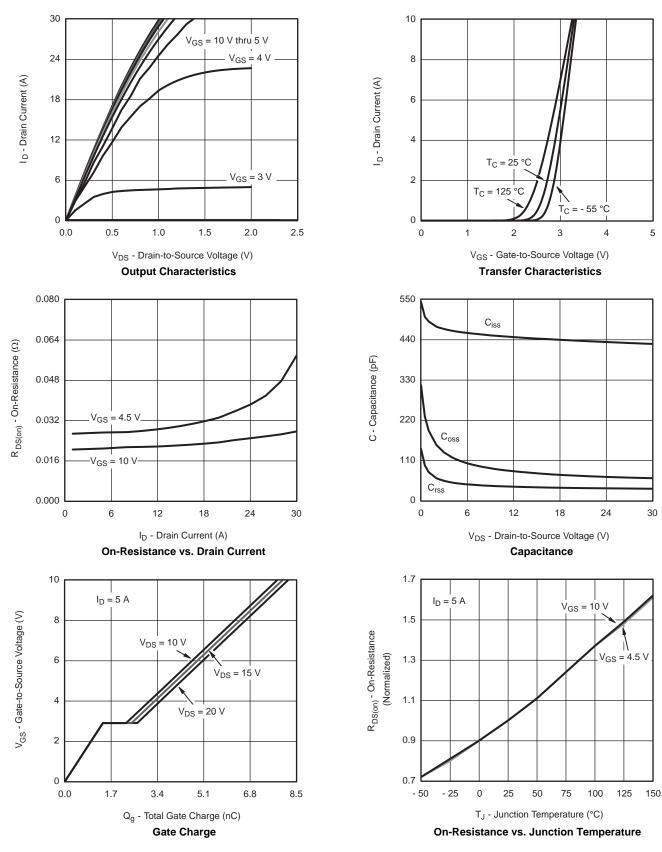
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

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 $I_D = 5 A$

T_J = 125 °C

T_J = 25 °C

8 9 10

6 7

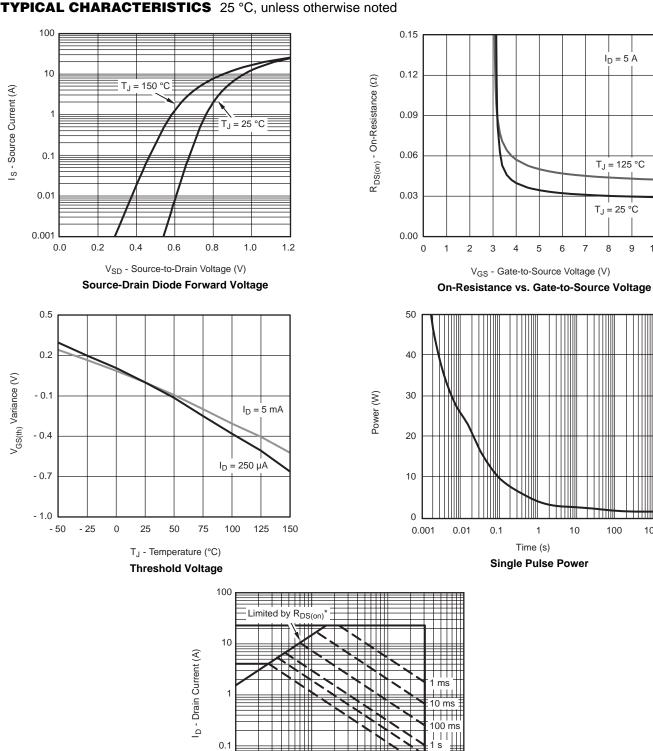
5

1

10

100

1000



T_A = 25 °C Single Pulse

0.01 0.1 111

1

BVDSS Limited

V_{DS} - Drain-to-Source Voltage (V) * V_{GS} > minimum V_{GS} at which $R_{DS(on)}$ is specified Safe Operating Area, Junction-to-Ambient

11111

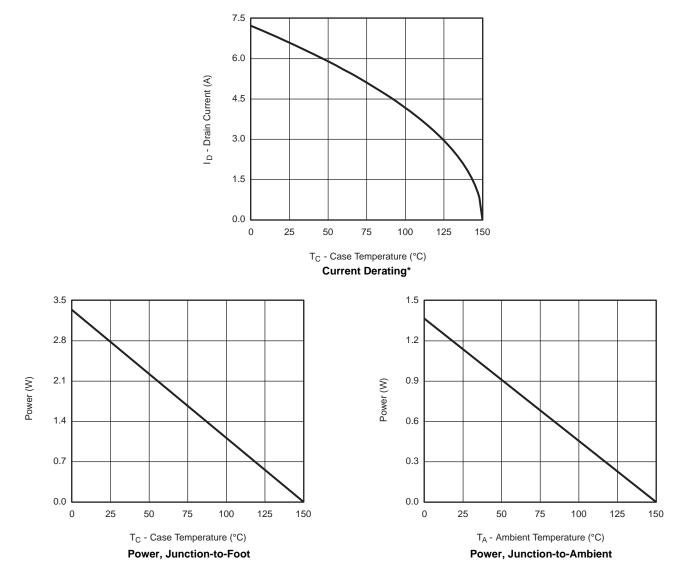
10

100

TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



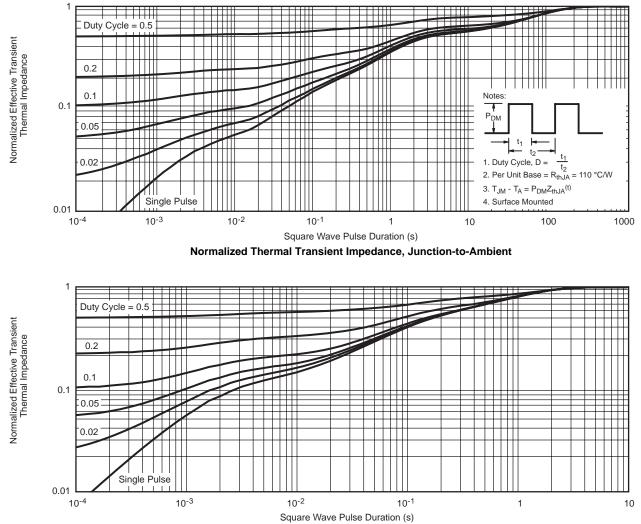
TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



* The power dissipation P_D is based on $T_{J(max)}$ = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.



TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



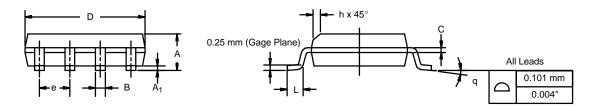
Normalized Thermal Transient Impedance, Junction-to-Foot



SOIC (NARROW): 8-LEAD

JEDEC Part Number: MS-012





MILLIMETERS		IETERS	INCHES			
DIM	Min	Max	Min	Max		
A	1.35	1.75	0.053	0.069		
A ₁	0.10	0.20	0.004	0.008		
В	0.35	0.51	0.014	0.020		
С	0.19	0.25	0.0075	0.010		
D	4.80	5.00	0.189	0.196		
E	3.80	4.00	0.150	0.157		
е	1.27 BSC		0.050	0.050 BSC		
н	5.80	6.20	0.228	0.244		
h	0.25	0.50	0.010	0.020		
L	0.50	0.93	0.020	0.037		
q	0°	8°	0°	8°		
S	0.44	0.64	0.018	0.026		
ECN: C-06527-Rev. I, 11-Sep-06 DWG: 5498						



RECOMMENDED MINIMUM PADS FOR SO-8



Recommended Minimum Pads Dimensions in Inches/(mm)



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Taiwan VBsemi Electronics Co., Ltd. hereby certify that all of its products comply identified as halogen-free halogen-free standards required by the JEDEC JS709A. Please note that some Taiwanese VBsemi documents still refer to the definition of IEC 61249-2-21, and we are sure that all products conform to confirm compliance with IEC 61249-2-21 standard level JS709A.